

Search Notes

Application/Control No.

10/692,269

Examiner

HABTE MERED

Applicant(s)/Patent under
Reexamination

LIAO ET AL.

Art Unit

2416

SEARCHED

Class	Subclass	Date	Examiner
370	230	5/14/2009	HM
370	230.1	5/14/2009	HM
370	231	5/14/2009	HM
370	232	5/14/2009	HM
370	233	5/14/2009	HM
370	234	5/14/2009	HM
370	449	5/14/2009	HM
709	225-229	5/14/2009	HM
455	450	5/14/2009	HM
455	452.1	5/14/2009	HM
455	452.2	5/14/2009	HM
455	453	5/14/2009	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched East DB:USPAT, USPG-Pub, EPO and JPO	5/14/2009	HM
Searched IEEE	5/14/2009	HM
Searched Palm Inventor's DB	5/14/2009	HM
Consulted with SPE (A. Moe) on rejection strategy and allowable subject matter	5/12/2009	HM